## Application/Control No. Applicant(s)/Patent Under Reexamination 10/068,278 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2622 Cheukfan Lee **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 07-1999 Takahashi et al. 348/65 Α US-5,929,899 В US-С US-D US-Ε US-F US-G US-Н USı US-US-J US-K L US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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